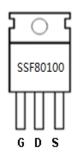
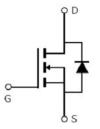


Main Product Characteristics:

V _{DSS}	75V
R _{DS} (on)	8mΩ(typ.)
I _D	80A ①







TO220

Marking and pin
Assignment

Schematic diagram

Features and Benefits:

- Advanced MOSFET process technology
- Special designed for motor control, PWM, load switching etc.
- Ultra low on-resistance with low gate charge
- Excellent Qgd/Qgs rating
- Fast switching and reverse body recovery
- 175°C operating temperature



Description:

It utilizes the latest processing techniques to achieve the high cell density and reduces the on-resistance with high repetitive avalanche rating. These features combine to make this design an extremely efficient and reliable device for use in power switching application, motor control and a wide variety of other applications.

Absolute max Rating:

Symbol	Parameter	Max.	Units	
I _D @ TC = 25°C	Continuous Drain Current, V _{GS} @ 10V	80 ①		
I _D @ TC = 100°C	Continuous Drain Current, V _{GS} @ 10V	70 ①	Α	
I _{DM}	Pulsed Drain Current ②	320		
D @TC - 25°C	Power Dissipation ③	200	W	
P _D @TC = 25°C	Linear Derating Factor	2.0	W/°C	
V _{DS}	Drain-Source Voltage	75	V	
V _{GS} Gate-to-Source Voltage		± 20	V	
E _{AS}	Single Pulse Avalanche Energy @ L=0.3mH	375	mJ	
I _{AS}	Avalanche Current @ L=0.3mH	50	Α	
T _J T _{STG}	Operating Junction and Storage Temperature Range	-55 to + 175	°C	



Thermal Resistance

Symbol	Characterizes	Тур.	Max.	Units
$R_{ heta JC}$	Junction-to-case ③	_	0.75	°C/W
D	Junction-to-ambient (t \leq 10s) (4)	_	62	°C/W
$R_{\theta JA}$	Junction-to-Ambient (PCB mounted, steady-state) ④	_	40	°C/W

Electrical Characterizes $@T_A=25^{\circ}C$ unless otherwise specified

Symbol	Parameter	Min.	Тур.	Max.	Units	Conditions	
V _{(BR)DSS}	Drain-to-Source breakdown voltage	75	_	_	V	V _{GS} = 0V, ID = 250μA	
ר	Statia Drain to Source on registance	_	8	10	mΩ	V _{GS} =10V,I _D = 30A	
$R_{DS(on)}$	Static Drain-to-Source on-resistance	_	14.9	_		T _J = 125℃	
V	Cata threshold voltage	2	_	4	V	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	
$V_{GS(th)}$	Gate threshold voltage	_	2.11	_	V	T _J = 125℃	
1	Drain to Course leakage gurrent	_	_	1		$V_{DS} = 75V, V_{GS} = 0V$	
I _{DSS}	Drain-to-Source leakage current	_	_	50	μA	T _J = 125℃	
1	Cata to Source forward lookage	_	_	100	n A	V _{GS} =20V	
I _{GSS}	Gate-to-Source forward leakage	_	_	-100	nA	V _{GS} = -20V	
Q_g	Total gate charge	_	73	_		I _D = 30A,	
Q _{gs}	Gate-to-Source charge	_	29	_	nC	V _{DS} =30V,	
Q_{gd}	Gate-to-Drain("Miller") charge	_	23	_		V _{GS} = 10V	
t _{d(on)}	Turn-on delay time	_	19	_		V _{GS} =10V, VDS=30V,	
t _r	Rise time	_	18	_			
t _{d(off)}	Turn-Off delay time	_	56	_	ns	$R_L=15\Omega$,	
t _f	Fall time	_	24	_		R_{GEN} =2.5 Ω	
C _{iss}	Input capacitance	_	4308	_		V _{GS} = 0V	
Coss	Output capacitance	_	328	_	pF	V _{DS} = 25V	
C _{rss}	Reverse transfer capacitance	_	118	_		f = 1MHz	

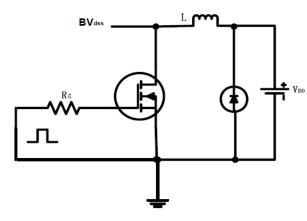
Source-Drain Ratings and Characteristics

Symbol	Parameter	Min.	Тур.	Max.	Units	Conditions
Is	Continuous Source Current		1	80 ①	А	MOSFET symb
	(Body Diode)					showing the
I _{SM}	Pulsed Source Current		_	320	А	integral reverse
	(Body Diode)	_				p-n junction diode.
V _{SD}	Diode Forward Voltage	_	0.88	1.3	V	I _S =30A, V _{GS} =0V
t _{rr}	Reverse Recovery Time	_	36	_	ns	$T_J = 25^{\circ}C$, $I_F = 75A$, $di/dt =$
Q _{rr}	Reverse Recovery Charge	_	50	_	nC	100A/μs

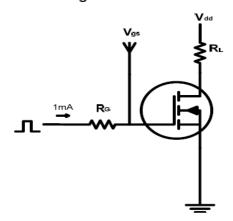


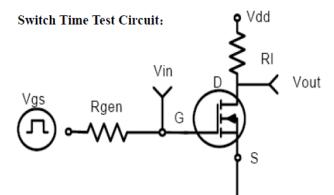
Test circuits and Waveforms

EAS test circuits:

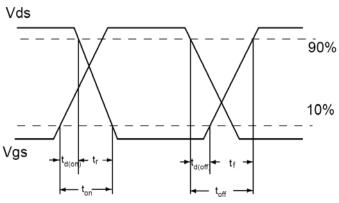


Gate charge test circuit:





Switch Waveforms:

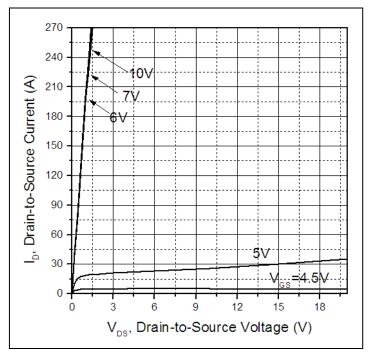


Notes:

- ①Calculated continuous current based on maximum allowable junction temperature. Package limitation current is 75A.
- ②Repetitive rating; pulse width limited by max. junction temperature.
- ③The power dissipation PD is based on max. junction temperature, using junction-to-case thermal resistance.
- 4The value of $R_{\texttt{9JA}}$ is measured with the device mounted on 1 in 2 FR-4 board with 2oz. Copper, in a still air environment with TA =25°C
- ⑤These curves are based on the junction-to-case thermal impedence which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of $T_{J(MAX)}=175$ °C.



Typical electrical and thermal characteristics



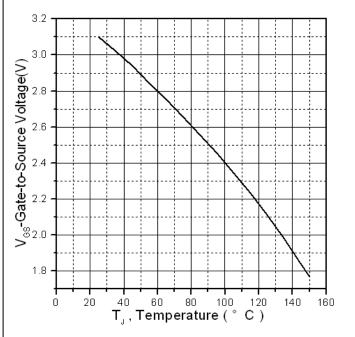


Figure 1: Typical Output Characteristics

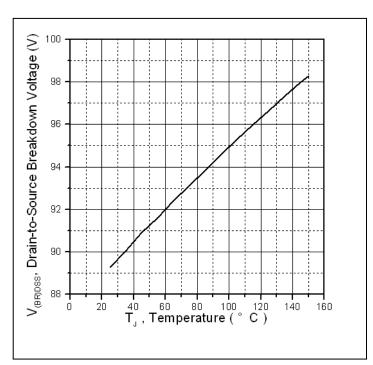


Figure 2. Gate to source cut-off voltage

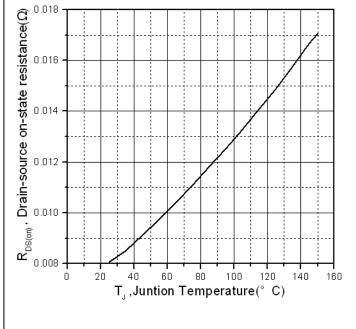
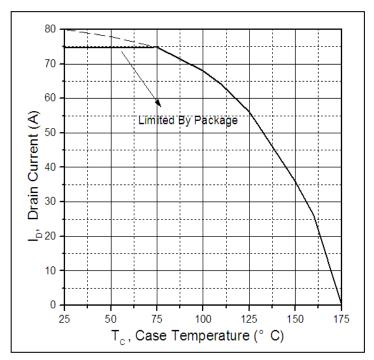


Figure 3. Drain-to-Source Breakdown Voltage vs.
Temperature

Figure 4: Normalized On-Resistance Vs. Case Temperature



Typical electrical and thermal characteristics



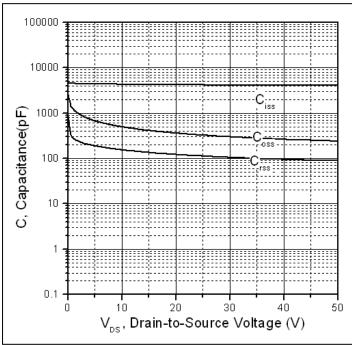


Figure 5. Maximum Drain Current Vs. Case Temperature

Figure 6.Typical Capacitance Vs. Drain-to-Source Voltage

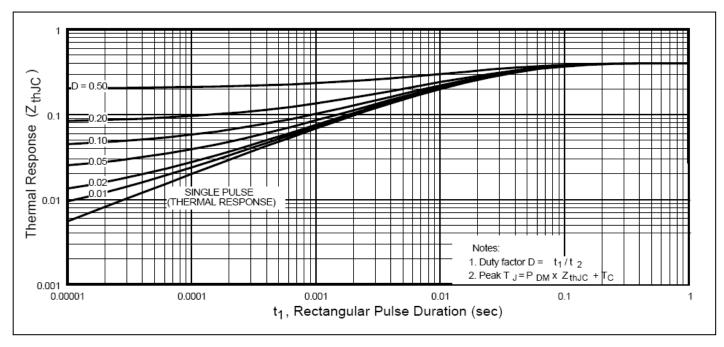
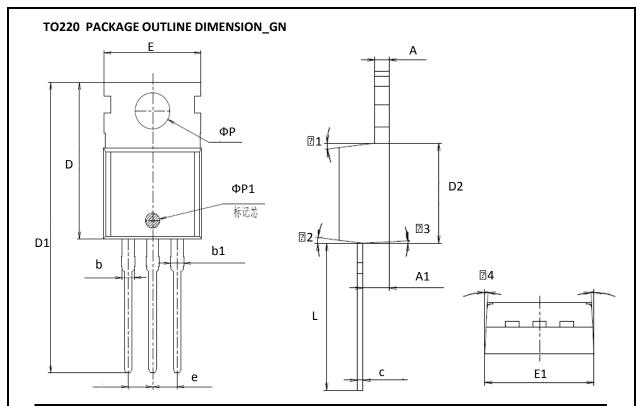


Figure 7. Maximum Effective Transient Thermal Impedance, Junction-to-Case



Mechanical Data:



Symbol	Dime	nsion In Millin	neters	Dimension In Inches			
Symbol	Min	Nom	Max	Min	Nom	Max	
Α	-	1.300	-	-	0.051	-	
A1	2.200	2.400	2.600	0.087	0.094	0.102	
b	-	1.270	-	-	0.050	-	
b1	1.270	1.370	1.470	0.050	0.054	0.058	
С	-	0.500	-	-	0.020	-	
D	-	15.600	-	-	0.614	-	
D1	-	28.700	-	-	1.130	-	
D2	-	9.150	-	-	0.360	-	
Е	9.900	10.000	10.100	0.390	0.394	0.398	
E1	-	10.160	-	-	0.400	-	
ФР	-	3.600	-	-	0.142	-	
ФР1		1.500			0.059		
е		2.54BSC			0.1BSC		
L	12.900	13.100	13.300	0.508	0.516	0.524	
Θ1	-	7 ⁰	-	-	7 ⁰	-	
Θ2	-	7 ⁰	-	-	7 ⁰	-	
Θ3	-	3 ⁰	-	5 ⁰	7 ⁰	90	
Θ4	-	3 ⁰	-	1 ⁰	3 ⁰	5 ⁰	





Ordering and Marking Information

Device Marking: SSF80100

Package (Available)
TO220
Operating Temperature Range
C: -55 to 175 °C

Devices per Unit

Package Type	Units/ Tube	Tubes/Inner Box	Units/Inner Box	Inner Boxes/Carton	Units/Carton Box
Туре	Tube	Box	BOX	Box	Вох
TO220	50	20	1000	6	6000

Reliability Test Program

Test Item	Conditions	Duration	Sample Size
High	T _j =125℃ to 175℃ @	168 hours	3 lots x 77 devices
Temperature	80% of Max	500 hours	
Reverse	V _{DSS} /V _{CES} /VR	1000 hours	
Bias(HTRB)			
High	T _j =150℃ or 175℃ @	168 hours	3 lots x 77 devices
Temperature	100% of Max V _{GSS}	500 hours	
Gate		1000 hours	
Bias(HTGB)			



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